

Notice of References Cited	Application/Control No. 10/772,315		Applicant(s)/Patent Under Reexamination YOON ET AL.	
	Examiner Maria Veronica D. Ewald		Art Unit 1722	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,201,742	05-1980	Hendry, James W.	264/45.5
*	B	US-4,225,109	09-1980	Yotsutsuji et al.	249/111
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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